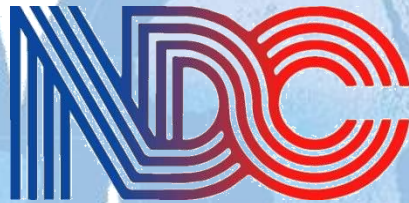


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# **Non-Nuclear Alternatives for On-Line Coating Thickness and Moisture Measurement**



Hector Marchand

Dave Atkinson

NDC Infrared Engineering

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# For Organic Coating Measurement, New Non-Nuclear Sensors Offer:

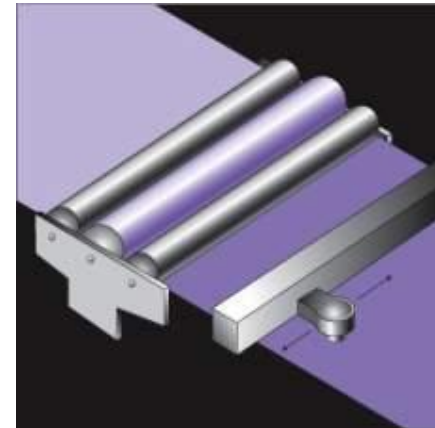
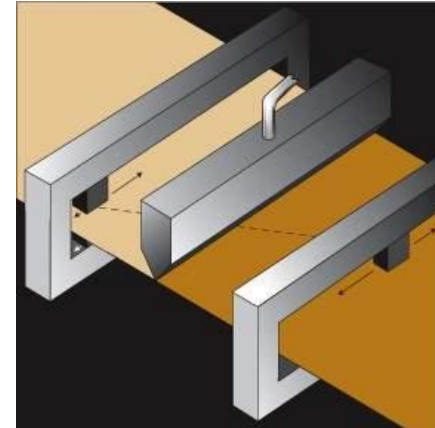
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- Greater Accuracy with Better Resolution
  - In Some Cases, Reduced Hardware Requirements
  - No or Minimized Government Regulatory Requirements
  - No Disposal Costs
  - Self-maintenance
  - ***Lower Lifetime Cost with Greater Lifetime Benefit***
-

# 2 Types of Common Non-Nuclear Gauges: Total Weight and Selective

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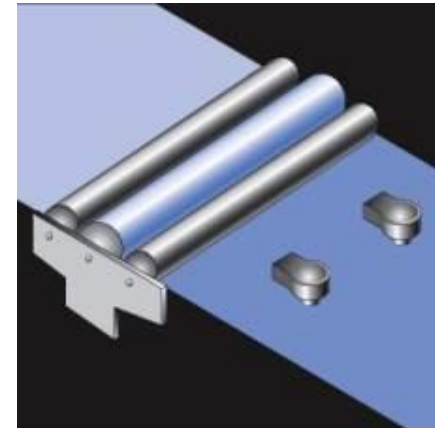
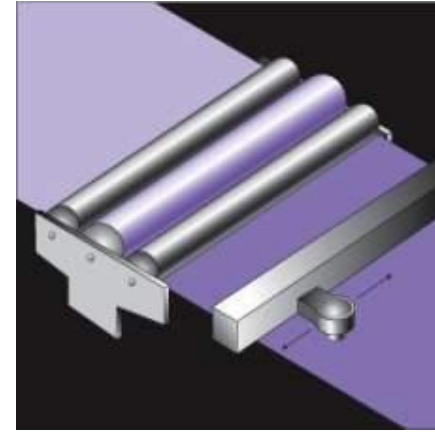
- Total Weight Gauges:
  - X-Ray Transmission and Backscatter
  - Measure total weight
  - Determining Coat weight requires differential measurement
    - Measure base stock, then measure total weight and subtract
    - Requires at least two sensors / scanners
- Direct Coat Weight Gauge:
  - Infrared gauge
  - Directly measures the coating
    - A single gauge / scanner does the job



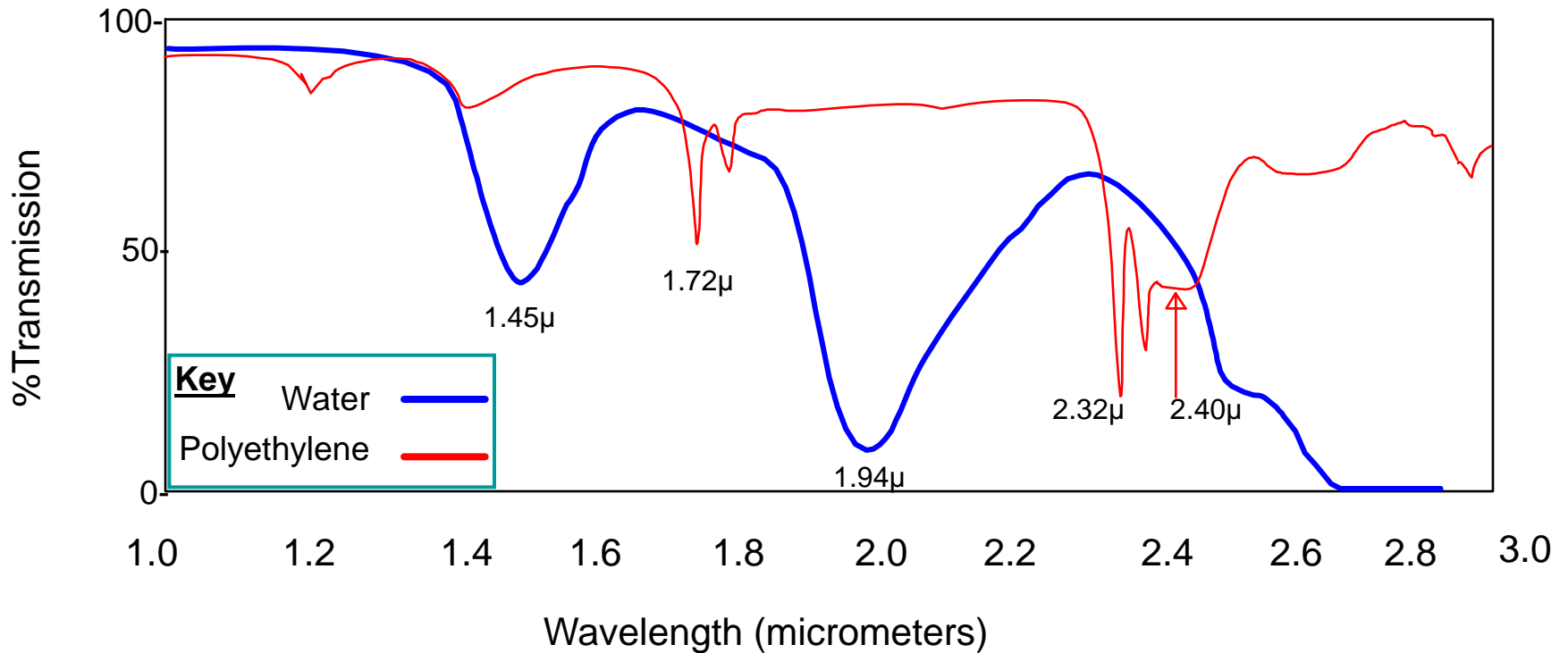
# Let's Discuss Selective Infrared Measurement Approach First

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- Selective approach requires only one gauge after the coating station
  - Less expensive
  - More accurate
- Scanning gauge
  - Common for Coating Measurement
- Single / Dual fixed gauge(s) (L/R)
  - Common for Moisture Measurement, Narrow / Slow Lines



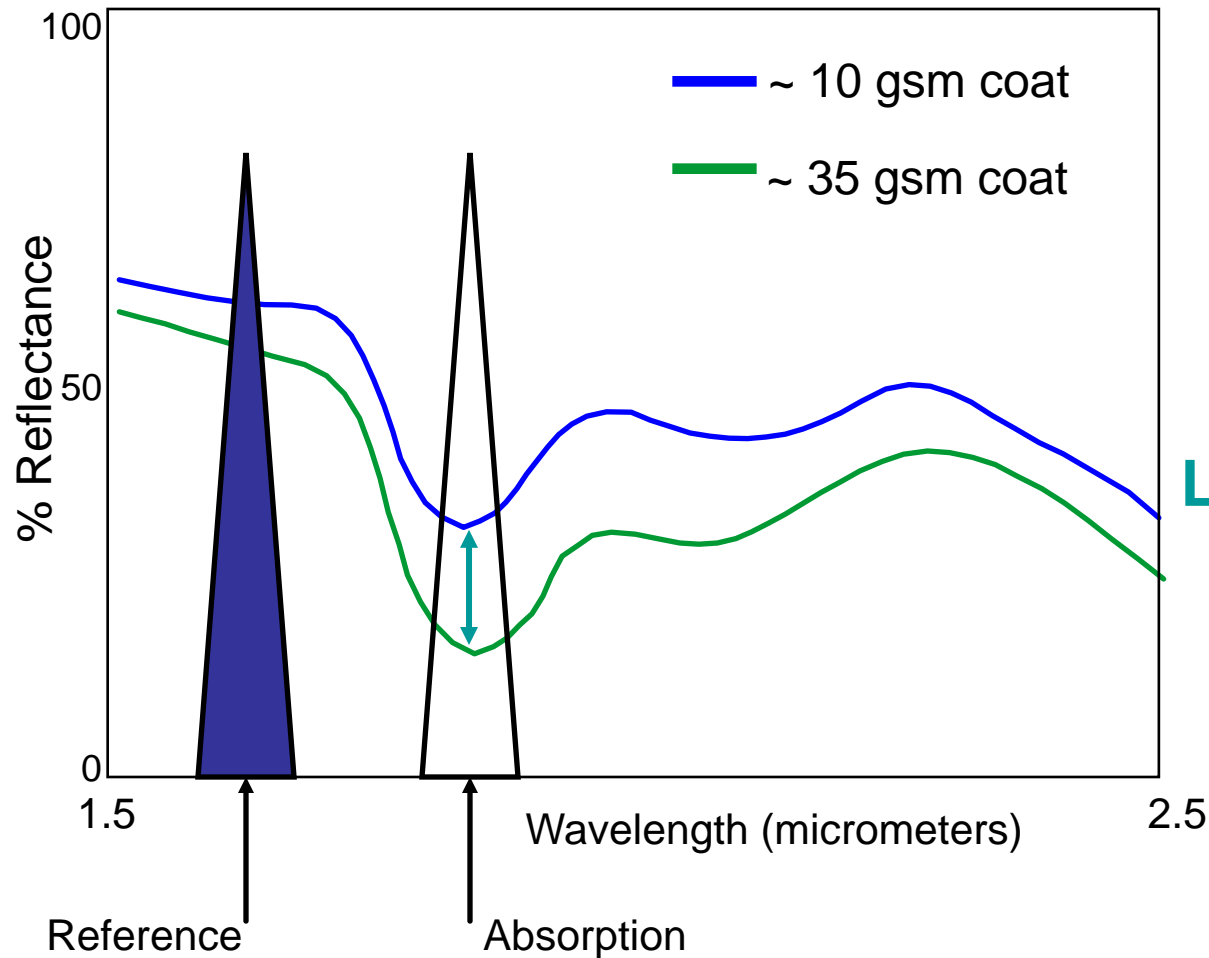
# Infrared is a Selective Technique



## Application example:

Thin water based coating on PE is trivial for IR

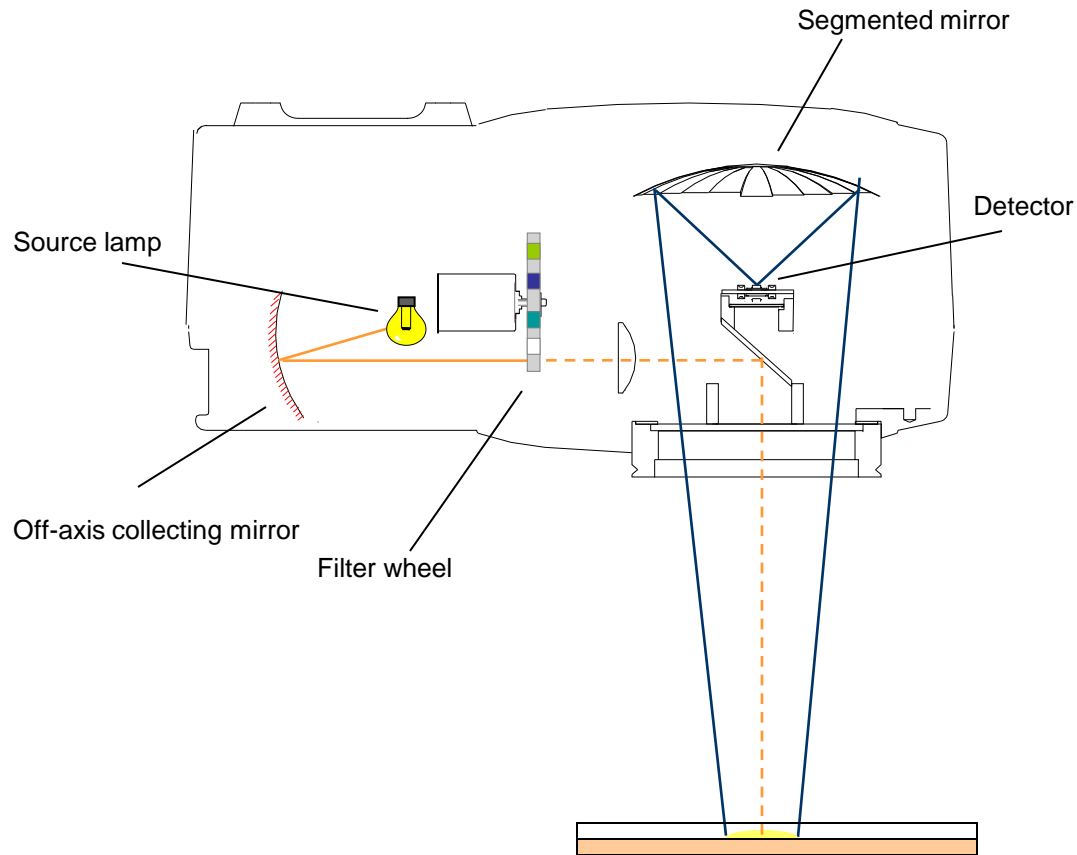
# Basic Two-Wavelength Measurement



“Absorption”  
absorbed by coating  
“Reference” NOT  
absorbed by coating

$$\text{Log} \left\{ \frac{\text{Sig} \lambda_{\text{ref}}}{\text{Sig} \lambda_{\text{abs}}} \right\} \propto \text{GSM}$$

# Infrared “Filter Wheel” Gauge Optical Schematic



# Typical IR Backscatter Gauge on Coating Application

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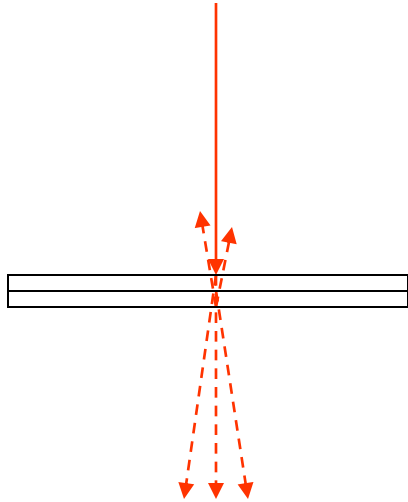


- Ranges / Accuracies:
- Moisture
  - Range: 0 – 90% moisture
  - Accuracy: 0.1%
- Coating Weight
  - Range: 0 – 1000 gsm
  - Accuracy: 0.1 gsm
- Note that these values are product / substrate dependent

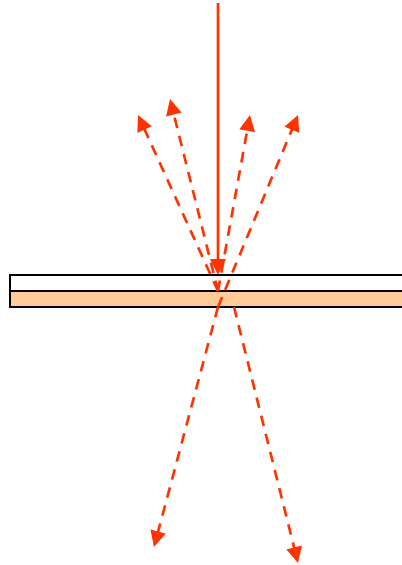


# Three types of IR energy behavior when interacting with various substrate types

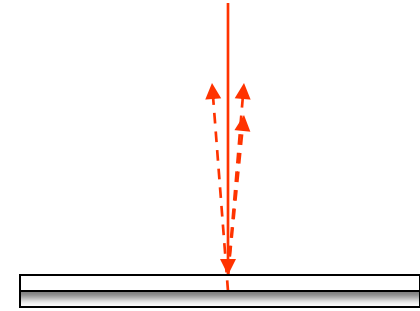
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Transmission -  
Clear Coatings  
on Clear Films



Diffusion -  
Clear Coatings on  
Pigmented Films, Paper



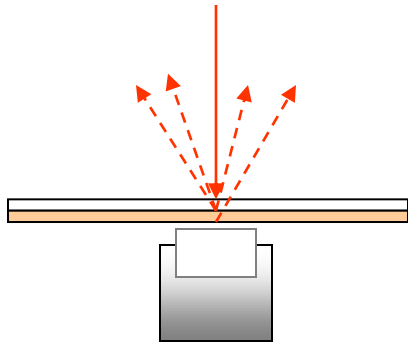
Specular Reflection -  
Clear Coatings on Metals,  
Foil, Metallized Films

**The Way Light interacts with the web has a direct influence  
on gauge design / optics**

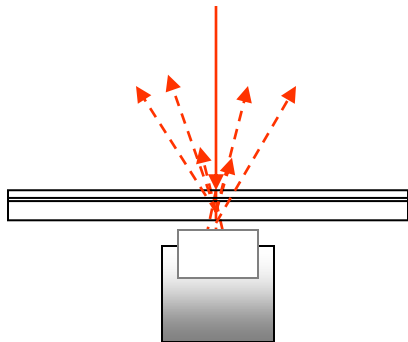
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# With IR Backscatter Running Multiple Substrate Types, Use Diffuse Reflector

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- With Diffuse Substrate, Reflector is Passive, Coating Measurement is Made



- With Clear Substrate, Reflector Sends Diffused IR Light back to Gauge Receiver, Enabling Measurement of Coating AND Film

When Running Clear, Diffuse, and Metallic Substrates, Use SR Gauge with Reflector

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# For Some Applications, Direct Selective Measurements are not Possible

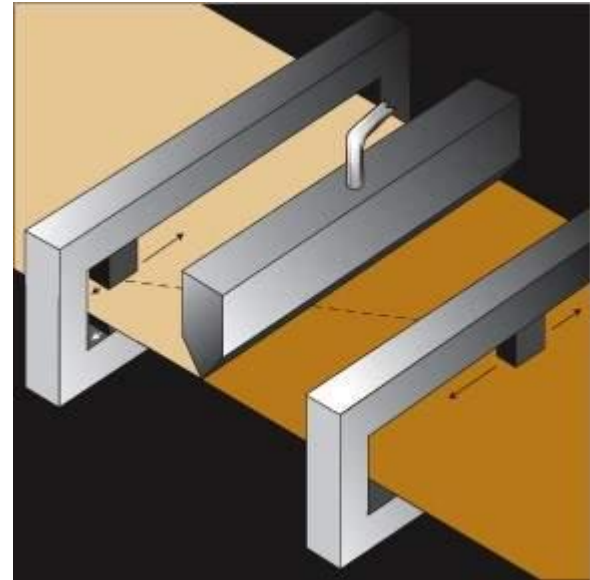
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- IR Selective technique does have limitations:
  - IR cannot measure opaque materials
  - Materials might be similar in composition
    - No discernable absorption band that measures just coating
- In these situations, a differential measurement may be the only solution

# Differential Measurement Technique Using Multiple Total Weight Gauges

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- First sensor reads substrate weight
- Second sensor reads total weight
- Gauge readings are “subtracted” to obtain coat weight



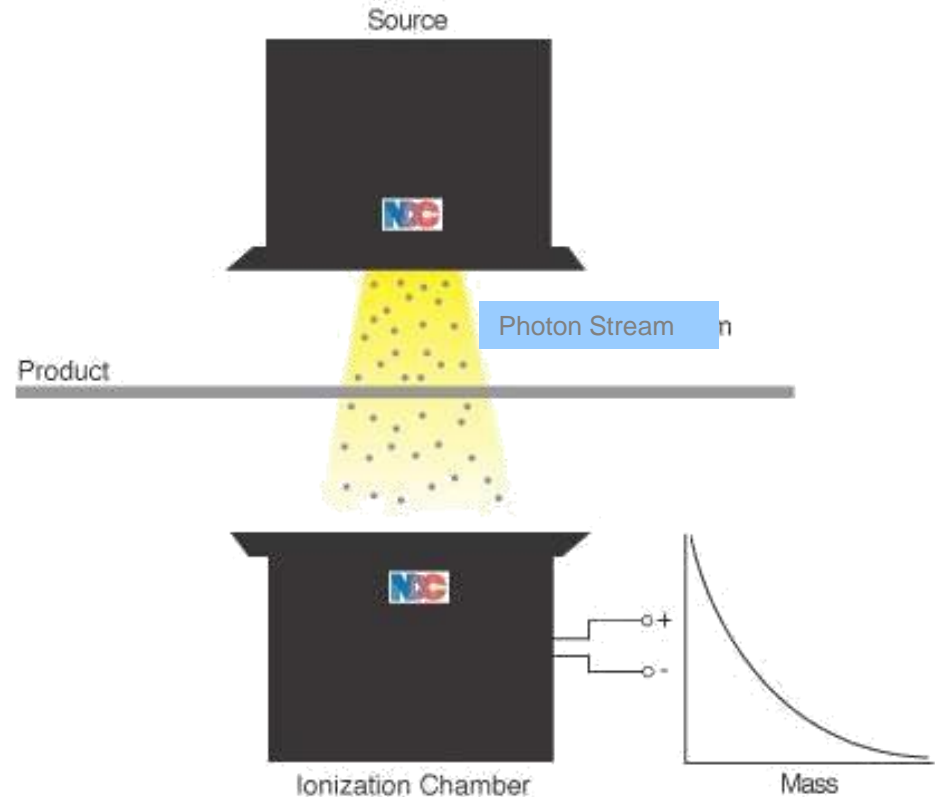
# X-Ray Sensor Types

- Transmission
  - High Resolution
    - Good Streak and Edge Detection
  - Excellent Repeatability
  - Composition Sensitivity can be problematic
  
- Backscatter
  - Less expensive
    - Single-sided Scanner
  - Less Composition Sensitive
  - Less Repeatable
  - Lower Resolution



# X-Ray Transmission

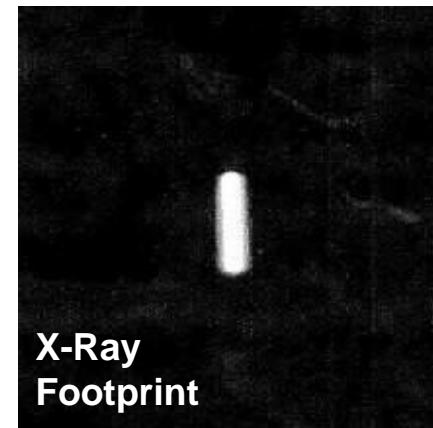
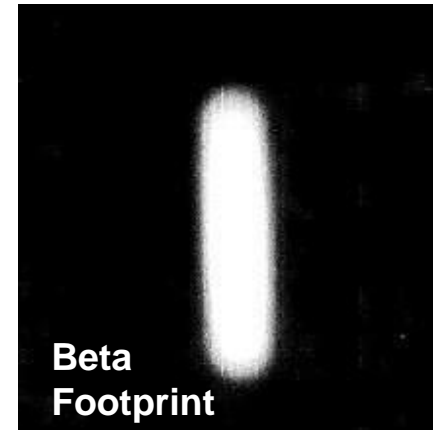
- Dual-sided sensor
- Generates photon stream through X-Ray tube, digital power supply
- Measurement range
  - Up to 10,000 gsm
- Some sensitivity to composition, presence of mineral / metal additives
- Total Weight Gauge
- Typical Repeatability: 0.1%



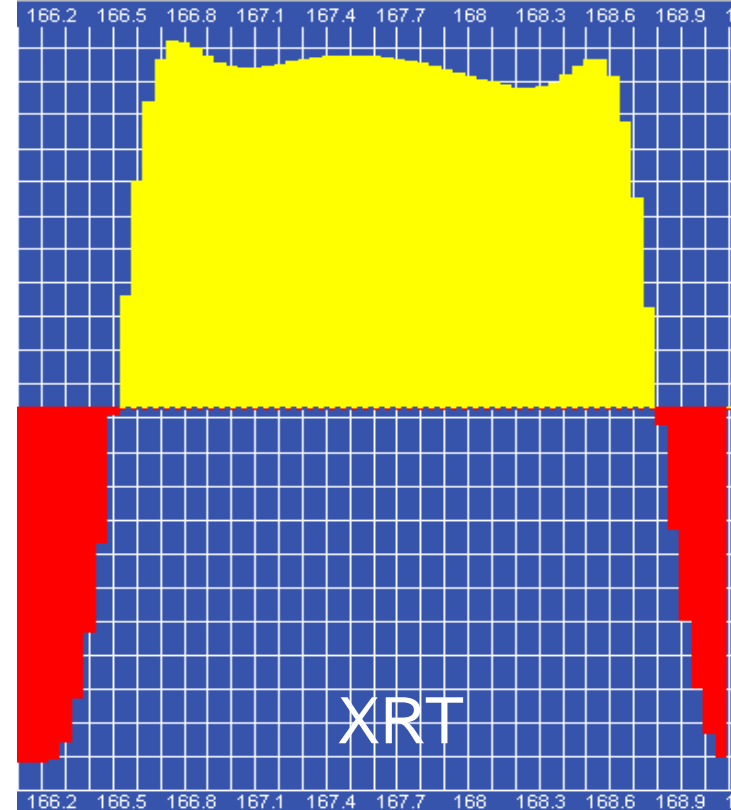
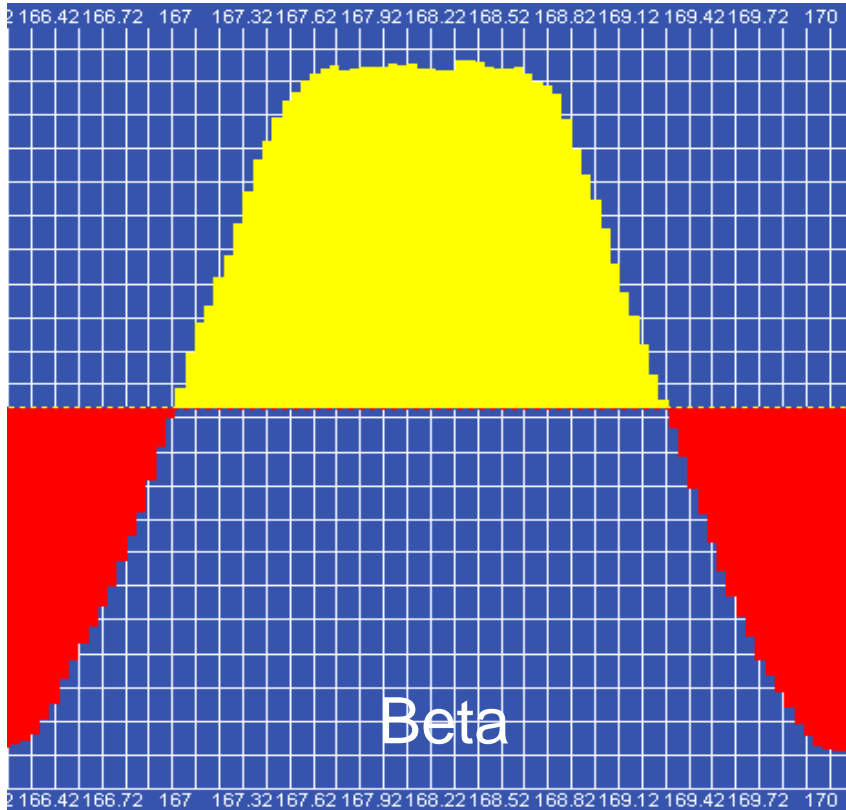
# XRT Offers Several Advantages over Nucleonic Gauges

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- Excellent Streak Resolution
- Higher Precision, Lower Noise
- Reduced Web Flutter Sensitivity
- Constant Output Over Time
- In Coating Applications, Gauge Readouts Can Be Easily Matched
  - Important for Improved True Net Coat
- With Power removed, no radiation



# XRT Sensor Profile Detail Vs Beta Gauge

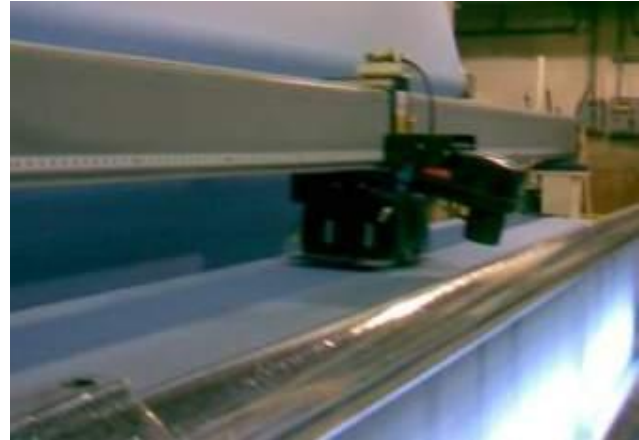


Magnification of 1/2" strip coating between 1/2" uncoated areas



# X-Ray Backscatter (XRB)

- X-Ray Tube generates photons; Ion Chamber measures reflected energy
- Total mass measurement gauge (wt/area)
- Single-sided Measurement
  - Less Expensive
- Range 10 – 25000 gsm
- Lower sensitivity to composition
- Typical Repeatability: 0.3%



# One Problem with Differential Approach: Accuracy is Function of **TOTAL** Mass

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- Differential Technique is viable when coat weight is a significant percentage of base weight
- Otherwise, cumulative errors render gauging approach useless
- Example, using gauges with 0.25% accuracy:

$$Err_{Coat} = \sqrt{Err_{Base}^2 + Err_{Gross}^2}$$

- Substrate = 100 gsm
- Coating = 3 gsm
- Coat error =  
SQRT ((100\*.0025)<sup>2</sup>+(103\*.0025)<sup>2</sup>)
- Coat weight error =  
0.36 gsm
- Coat weight error = **12%**

**Rule of Thumb: Coating Must be AT LEAST 10% of Substrate Weight**

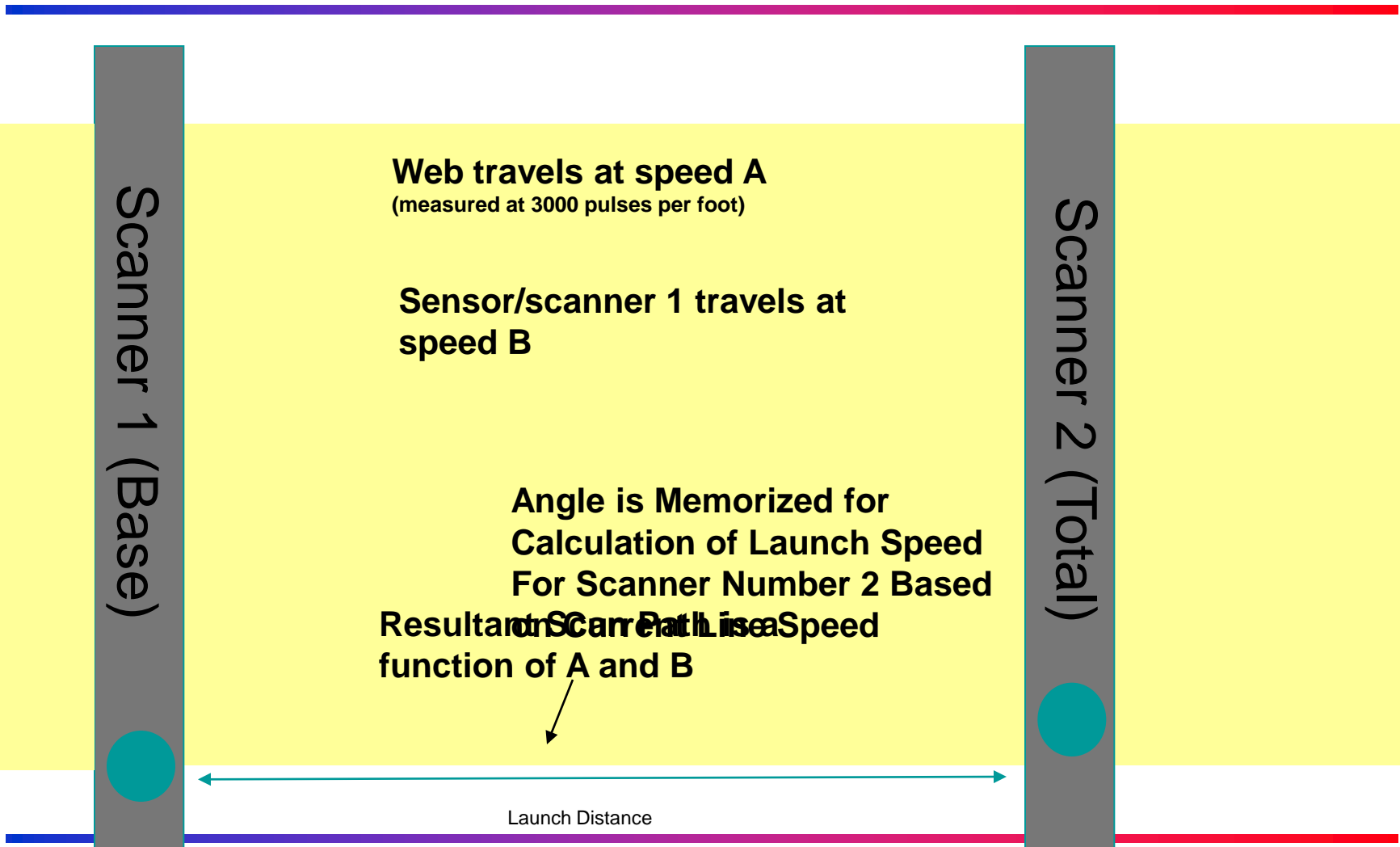
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# Other Challenges with Differential Technique and Typical Solutions

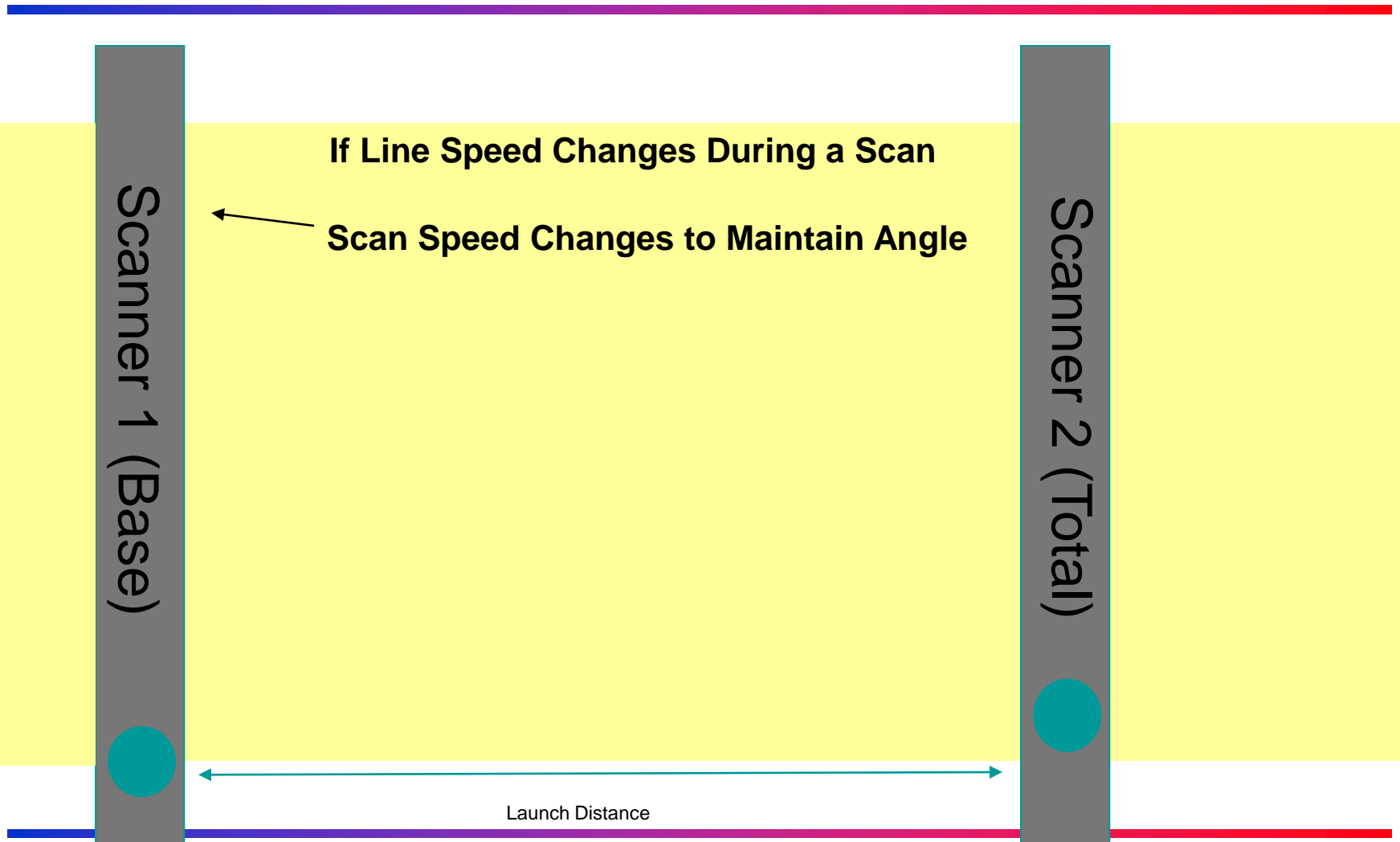
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- Substrate has basis weight variation
  - Provide accurate “Same Spot” method so that both sensors see same area of base material when making measurement
- Compositional effect
  - Use “True Net Coat” algorithm
    - Works well with XRB
    - Needs to be carefully applied with XRT

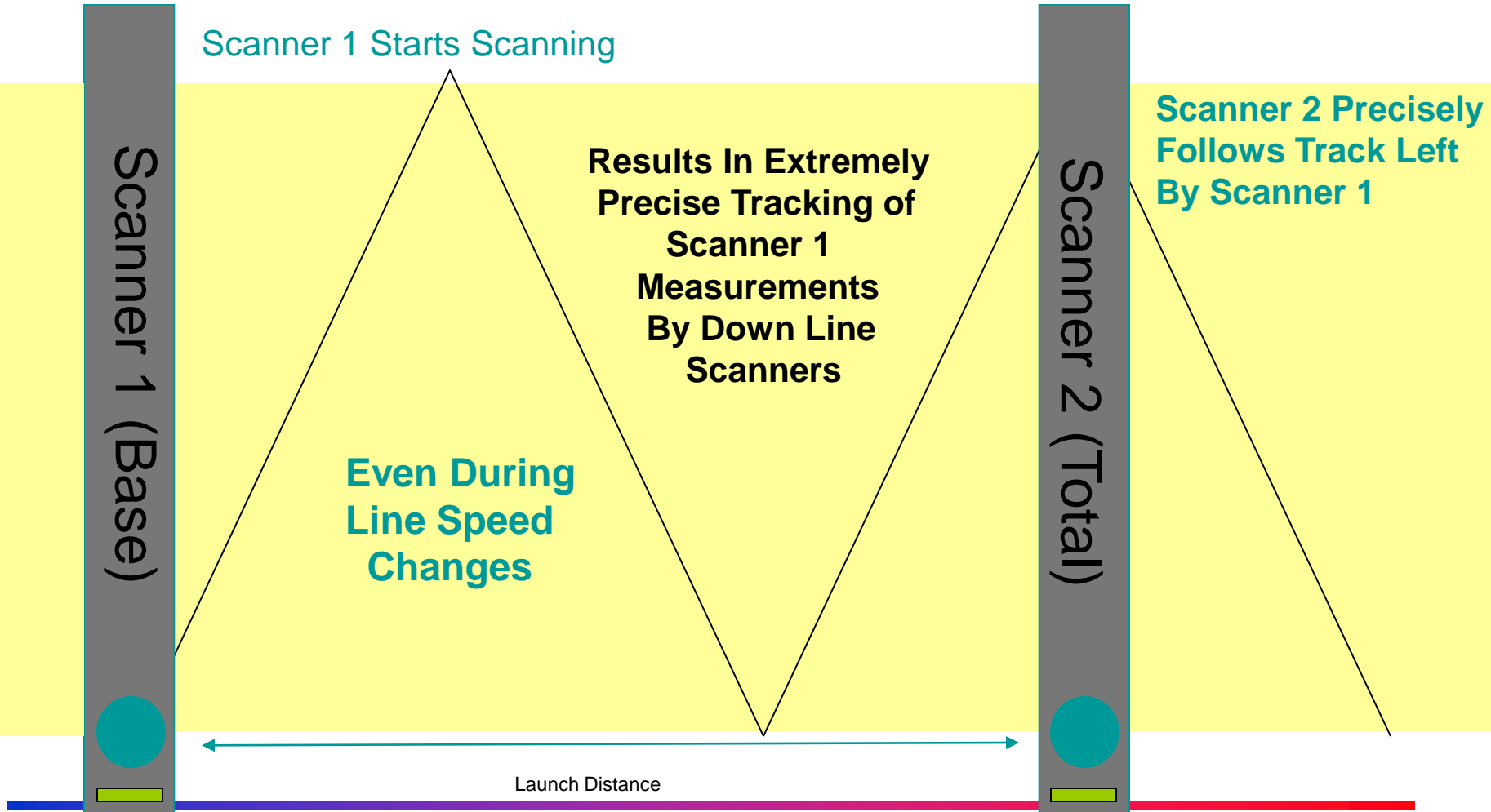
# Same Spot Measurement



# Same Spot Measurement



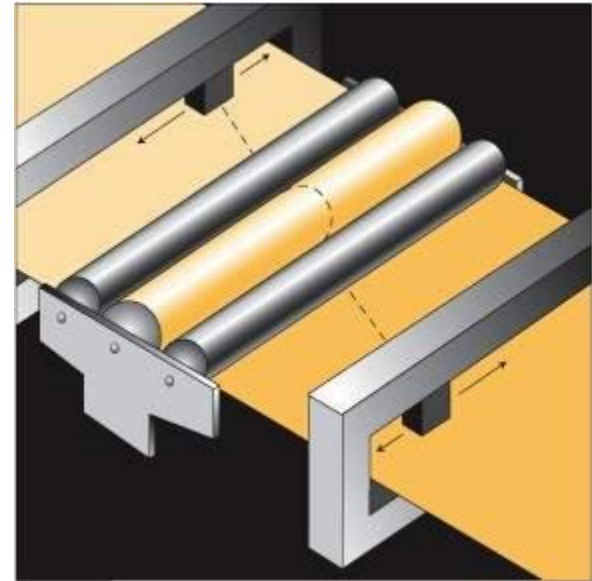
# The Result of Same Spot Measurement



# Keys to Good Same Spot Measurement

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- Launch of scanners based on distance, not time
  - Line speed can change
  - Use high resolution digital pulse encoder to control launch
- Scan speeds must be slaved to line speed
  - To maintain constant vector angle



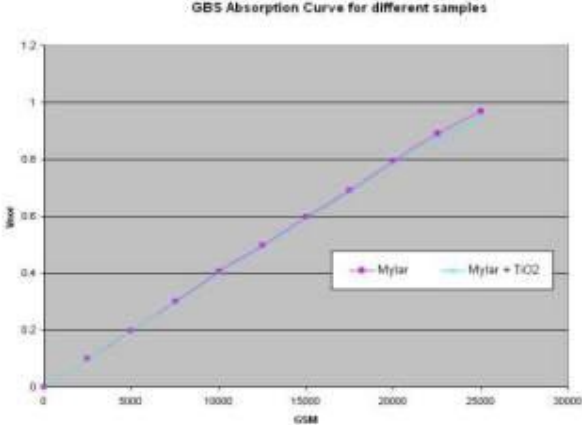
# Problem 2: Composition Sensitivity

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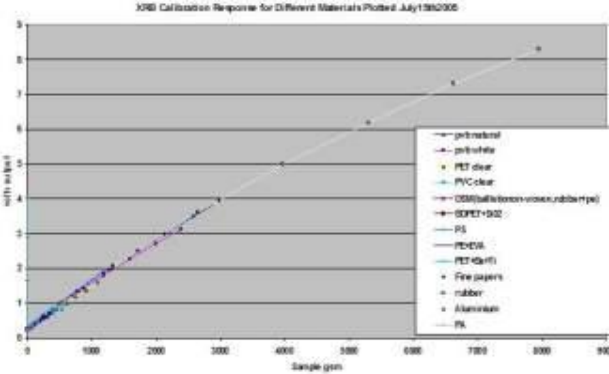
- With some types of gauges, composition of the material can change the reading
    - A function of Atomic weight / atomic number ratio
  - This effect can compound coat measurement errors as the substrate may have a different composition effect than does the coating
    - e.g.: Clear Organic Coating on Foil Substrate
    - e.g.: Pigmented Coating on Clear Substrate
  - In these cases, the system must incorporate a “True Net Coat” algorithm
-



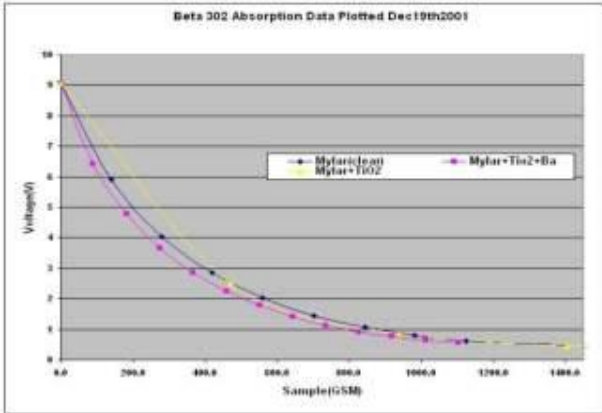
# Effect of Fillers on Various Sensor Types



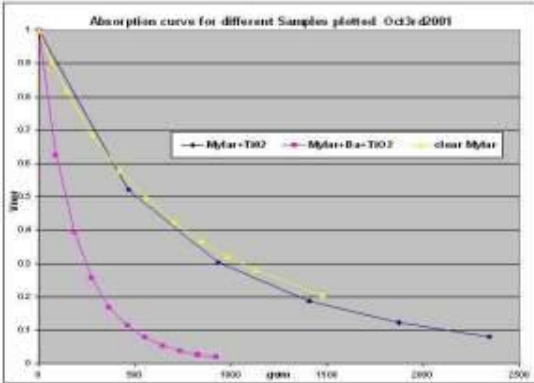
Gamma Backscatter



X-Ray Backscatter



Beta Transmission



X-Ray Transmission

# Final Comments:

## Non-Nuclear Gauge Selection

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- Accuracy with Differential Systems
  - Function of RMS of errors gauges employed, based on the TOTAL weight being measured
  - Accuracy only obtained as long as substrate variability and composition effects are managed
    - Same Spot / True Net Coat
- If Selective Infrared can be used, a better choice
  - Single scanner / sensor = Lower cost
  - Greater Accuracy
  - Ability to measure multiple constituents
    - Coating
    - Moisture
    - Polymeric Substrates
  - No Ionizing Radiation

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Questions?



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